

Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10516632	OSHIMA ET AL.
	Examiner Duong, Dieu Hien T	Art Unit 2821

SEARCHED

Class	Subclass	Date	Examiner
343	700ms, 711,712,713	01/31/0	DD

SEARCH NOTES

Search Notes	Date	Examiner
Please See East Search History	01/31/07	DD

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner
343	700ms,711,712,713	01/31/07	dd